S	earch No	tes

Application/Control No.	Applicant(s)/Patent unde Reexamination	er
10/775,637	TOJO ET AL.	
Examiner	Art Unit	
Ashok Patel	2870	

Γ			
	SEAR	CHED	
Class	Subclass	Date	Examiner
313	477R,461 479	10/1/2005	AP
220	2.1A 2.3A	10/1/2005	AP

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
		<del></del>	
	<u> </u>		

SEARCH NO (INCLUDING SEARCH	TES STRATEGY	7)
	DATE	EXMR
		<u> </u>